



8N40K-MTQ

Power MOSFET

8A, 400V N-CHANNEL POWER MOSFET

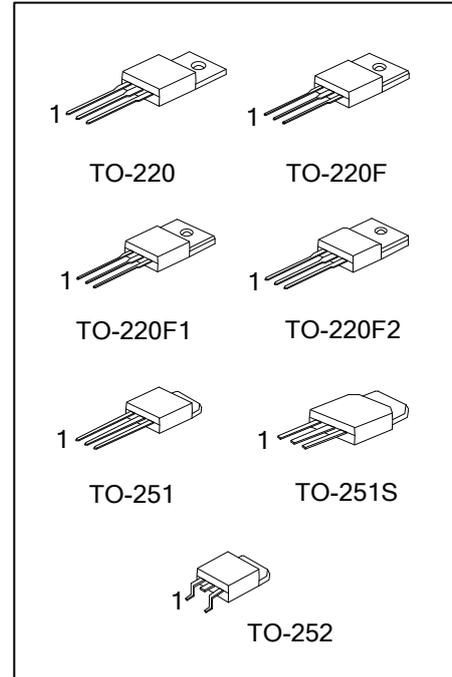
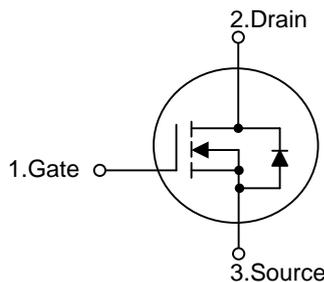
DESCRIPTION

The UTC **8N40K-MTQ** is an N-channel power MOSFET using UTC's advanced technology to provide the customers with minimum on-state resistance, superior switching performance and withstand high energy pulse in the avalanche and commutation mode.

FEATURES

- * $R_{DS(ON)} \leq 0.75 \Omega @ V_{GS}=10V, I_D=4.0A$
- * High switching speed
- * 100% avalanche tested

SYMBOL



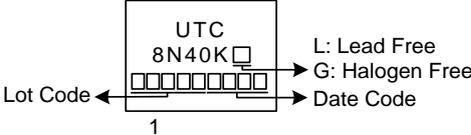
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
8N40KL-TA3-T	8N40KG-TA3-T	TO-220	G	D	S	Tube
8N40KL-TF1-T	8N40KG-TF1-T	TO-220F1	G	D	S	Tube
8N40KL-TF2-T	8N40KG-TF2-T	TO-220F2	G	D	S	Tube
8N40KL-TF3-T	8N40KG-TF3-T	TO-220F	G	D	S	Tube
8N40KL-TM3-T	8N40KG-TM3-T	TO-251	G	D	S	Tube
8N40KL-TMS-T	8N40KG-TMS-T	TO-251S	G	D	S	Tube
8N40KL-TN3-R	8N40KG-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

<p>8N40KG-TA3-T</p> <p>(1)Packing Type (2)Package Type (3)Green Package</p>	<p>(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TF3: TO-220F, TF1: TO-220F1, TF2: TO-220F2, TM3: TO-251, TMS: TO-251S TN3: TO-252 (3) G: Halogen Free and Lead Free, L: Lead Free</p>
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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	400	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current	Continuous (T _C =25°C)	I _D	8	A
	Pulsed (Note 2)	I _{DM}	32	A
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	210	mJ
	Repetitive (Note 2)	E _{AR}	2.5	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.4	V/ns
Power Dissipation	TO-220	P _D	95	W
	TO-220F/TO-220F1		32	W
	TO-220F2			
	TO-251/TO-251S TO-252		52	W
Junction Temperature		T _J	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 6.6mH, I_{AS} = 8.0A, V_{DD} = 50V, R_G = 25Ω, Starting T_J = 25°C

4. I_{SD} ≤ 8.0A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-220F	θ _{JA}	62.5	°C/W
	TO-220F1/TO-220F2			
	TO-251/TO-251S TO-252		110	
Junction to Case	TO-220	θ _{JC}	1.3	°C/W
	TO-220F/TO-220F1		3.9	
	TO-220F2			
	TO-251/TO-251S TO-252		2.4	

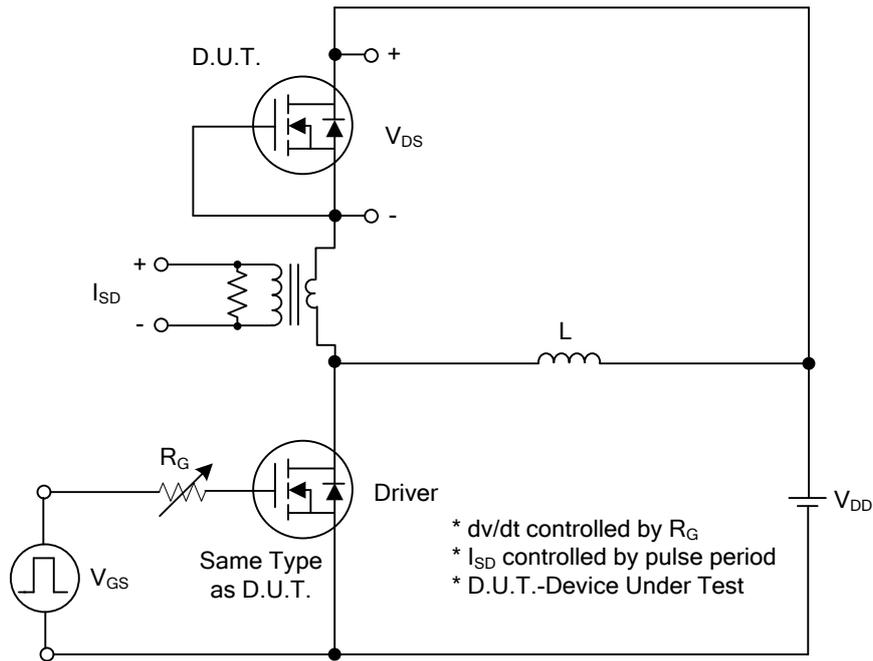
■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	400			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =400V, V _{GS} =0V			10	μA
Gate- Source Leakage Current	Forward	V _{GS} =+30V, V _{DS} =0V V _{GS} =-30V, V _{DS} =0V			+100	nA
	Reverse				-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250μA	2.0		4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4A			0.75	Ω
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		740		pF
Output Capacitance	C _{OSS}			92		pF
Reverse Transfer Capacitance	C _{RSS}			6		pF
SWITCHING PARAMETERS						
Total Gate Charge	Q _G	V _{DS} =320V, V _{GS} =10V, I _D =8A I _G =1mA (Note 1, 2)		16		nC
Gate to Source Charge	Q _{GS}			5		nC
Gate to Drain Charge	Q _{GD}			3		nC
Turn-ON Delay Time	t _{D(ON)}	V _{DD} =100V, V _{GS} =10V, I _D =8A, R _G =25Ω (Note 1, 2)		9		ns
Rise Time	t _R			20		ns
Turn-OFF Delay Time	t _{D(OFF)}			42		ns
Fall-Time	t _F			20		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Body-Diode Continuous Current	I _S				8	A
Maximum Body-Diode Pulsed Current	I _{SM}				32	A
Drain-Source Diode Forward Voltage	V _{SD}	I _S =8A, V _{GS} =0V			1.4	V
Reverse Recovery Time	t _{rr}	V _{GS} =0V, I _S =8A, di/dt=100A/μs		252		ns
Reverse Recovery Charge	Q _{rr}				4.7	

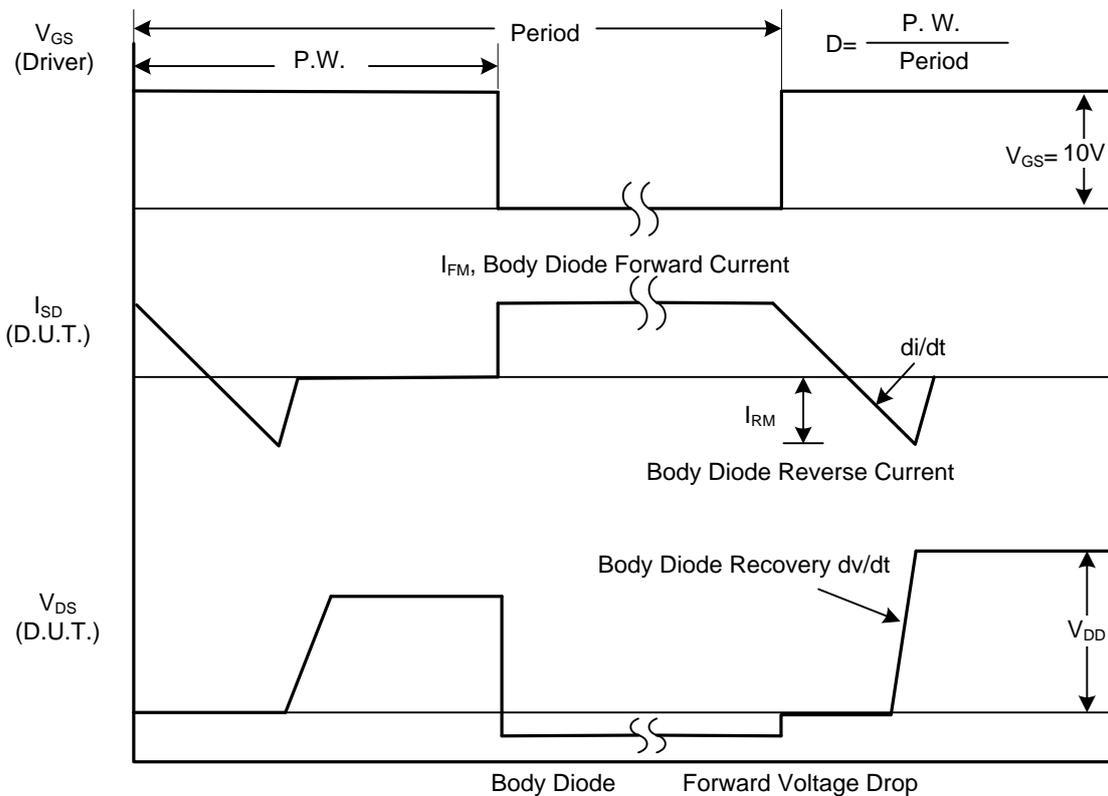
Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

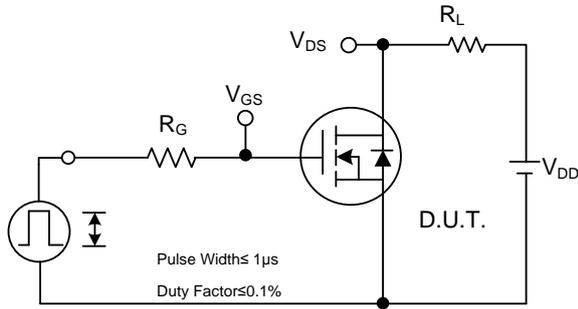


Peak Diode Recovery dv/dt Test Circuit

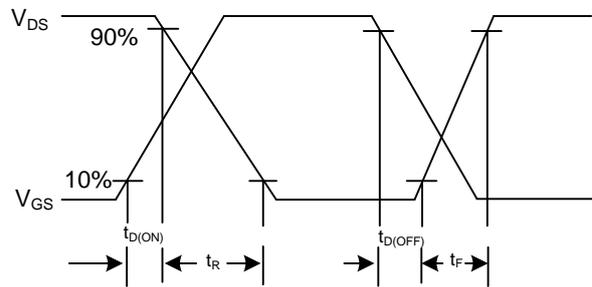


Peak Diode Recovery dv/dt Waveforms

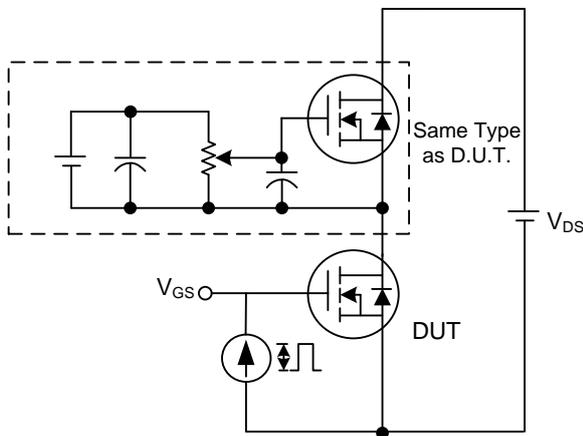
TEST CIRCUITS AND WAVEFORMS



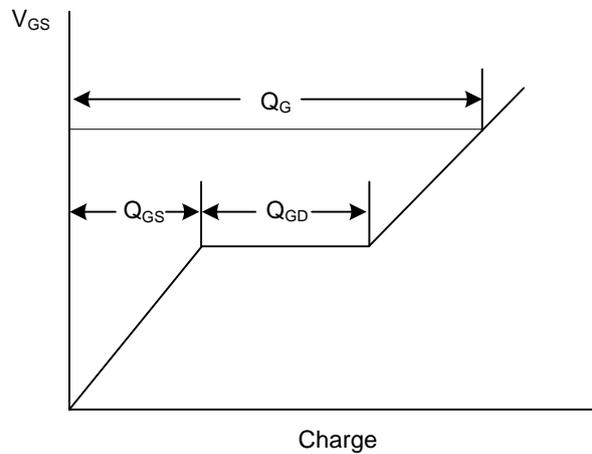
Switching Test Circuit



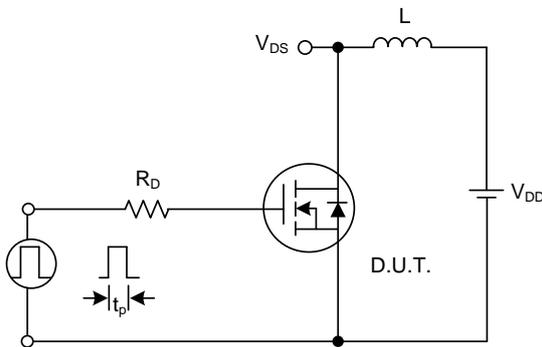
Switching Waveforms



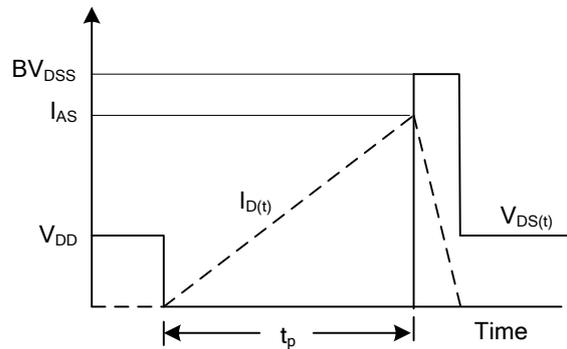
Gate Charge Test Circuit



Gate Charge Waveform

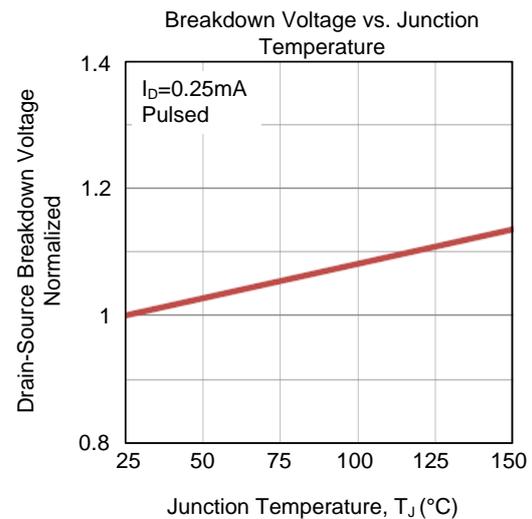
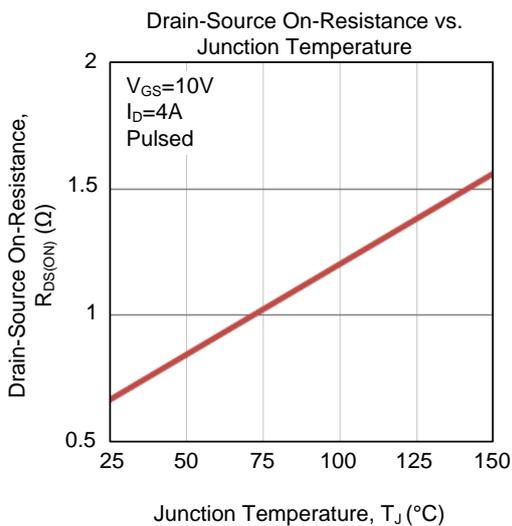
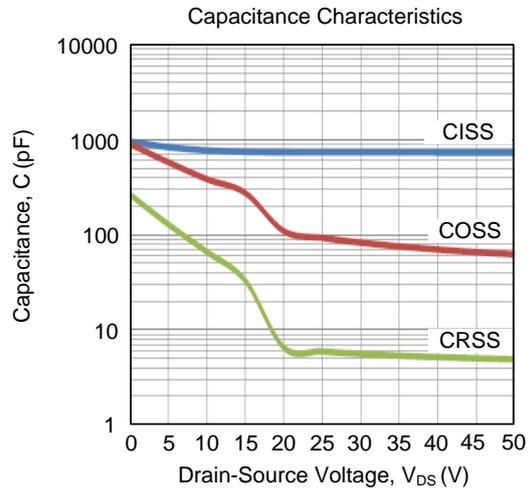
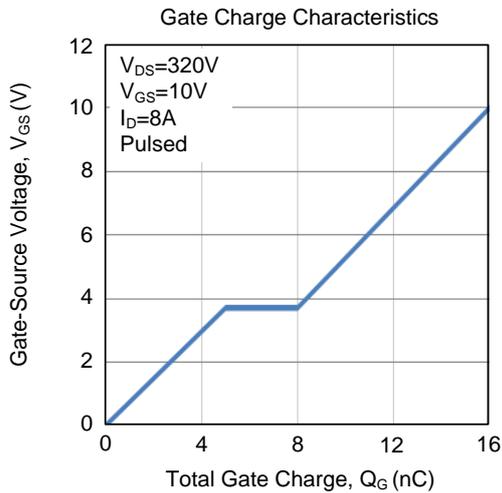
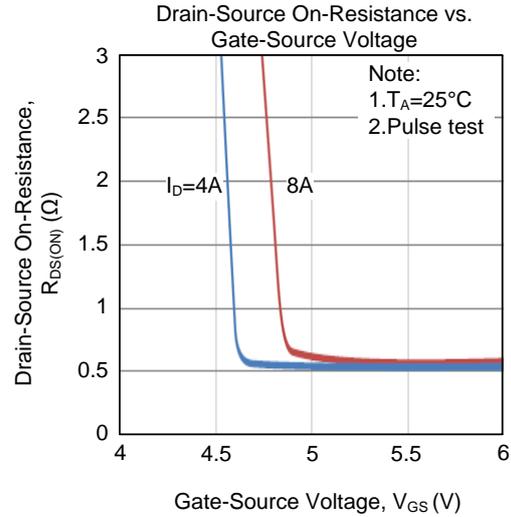
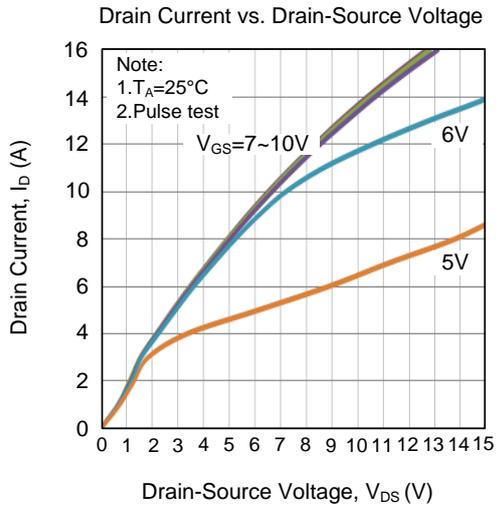


Unclamped Inductive Switching Test Circuit

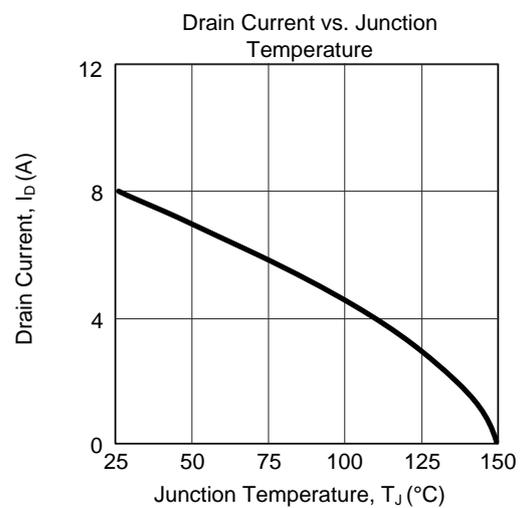
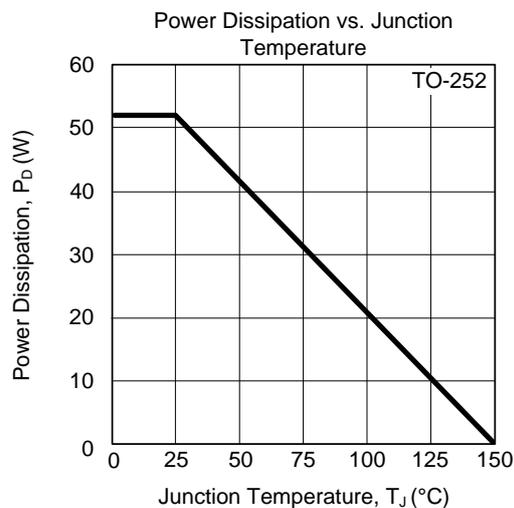
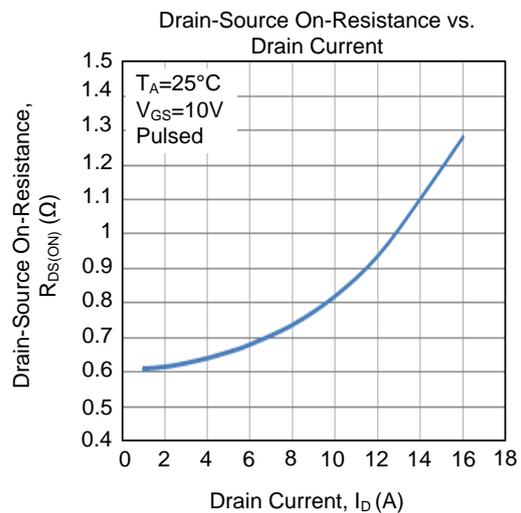
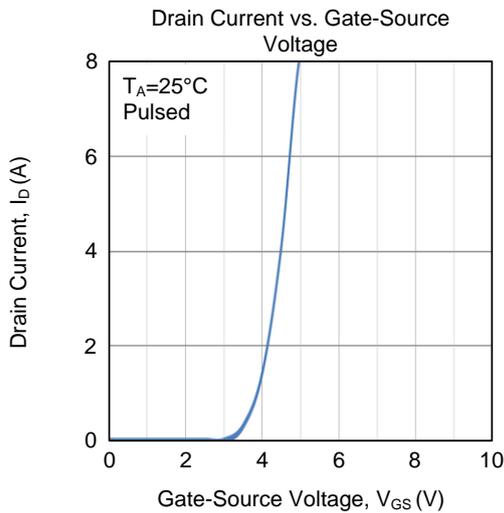
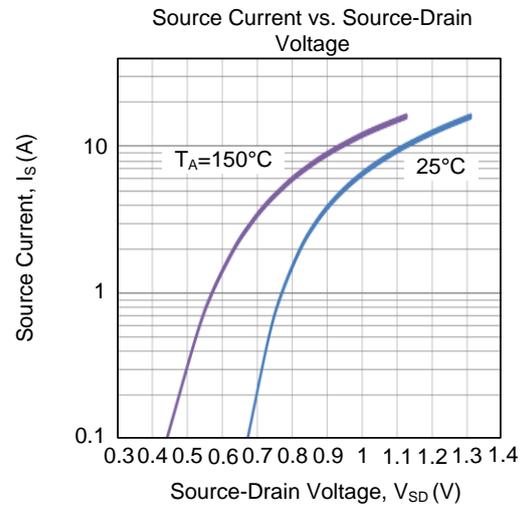
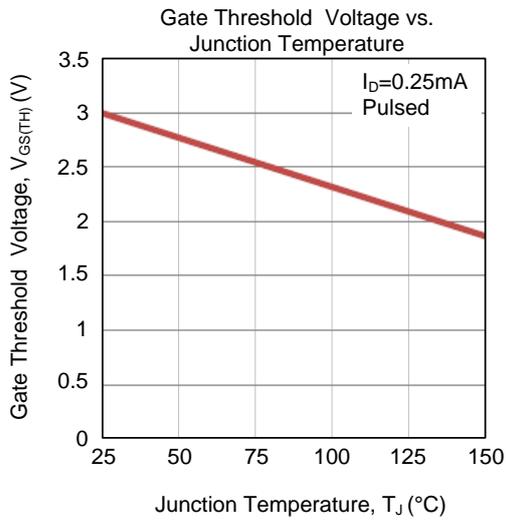


Unclamped Inductive Switching Waveforms

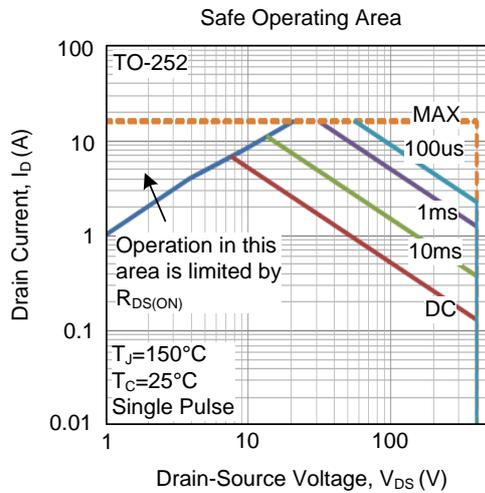
TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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